


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551900	<b>Applicant(s)/Patent Under Reexamination</b>  YASUO ET AL.
	<b>Examiner</b>  Mark Kopec	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
505	237, 238, 239, 434, 440, 470, 818	01/31/08	M.K.
428	699-702, 930	"	"
427	62, 126.3,	"	"
ABOVE	TO DATE	08/29/08	M.K.

SEARCH NOTES			
Search Notes		Date	Examiner
Inv. Name Search (PALM)		01/31/08	M.K.
EAST		"	"
Reviewed 210 search report		"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
PG-PUB		08/28/08	M.K.

	/Mark Kopec/ Primary Examiner.Art Unit 1796
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